Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/611,638	WULFF, THOMAS
Examiner	Art Unit
James K. Trujillo	2116

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SEARCHED						
Class	Subclass	Date	Examiner			
429	96,97	1/22/2007	JKT			
320	112	1/24/2007	JKT			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP	9/1/2006	JKT		
Updated text search, see attached	1/24/2007	JKT		
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